

Notice of References Cited	Application/Control No. 10/065,262	Applicant(s)/Patent Under Reexamination SCAGGS, MICHAEL J.	
	Examiner Richard Bueker	Art Unit 1763	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,669,979	09-1997	Elliott et al.	134/1
	B	US-6,066,032	05-2000	Borden et al.	451/80
	C	US-6,827,816	12-2004	Uziel et al.	156/345.39
	D	US-6,565,927	05-2003	Drzal et al.	427/487
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Zapka, 'Efficient pulsed laser removal of 0.2 micron sized particles from a solid surface', Appl. Phys. Lett. 58 (20), 20 May 1991.
	V	Tam, 'Laser-cleaning techniques for removal of surface particulates', J. Appl. Phys. 71(7), 1 April 1992.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.